

Optoelectronic and Spectroscopic Characterization of Vapour-Transport Grown $\text{Cu}_2\text{ZnSnS}_4$ Single Crystals

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Single crystals of $\text{Cu}_2\text{ZnSnS}_4$ (CZTS) have been grown by iodine vapor transport with and without addition of NaI. Crystals with tin-rich copper-poor and with zinc-rich copper-poor stoichiometries were obtained. The crystals were characterized by single crystal X-ray diffraction, energy-dispersive X-ray spectroscopy, photocurrent spectroscopy and electroreflectance spectroscopy using electrolyte contacts as well as by spectroscopic ellipsometry, Raman spectroscopy and photoluminescence spectroscopy (PL) /decay. Near-resonance Raman spectra indicate that the CZTS crystals adopt the kesterite structure with near-equilibrium residual disorder. The corrected external quantum efficiency of the p-type crystals measured by photocurrent spectroscopy approaches 100% close to the bandgap energy, indicating efficient carrier collection. The bandgap of the CZTS crystals estimated from the external quantum efficiency spectrum measured using an electrolyte contact was found to be 1.64 – 1.68 eV. An additional sub-bandgap photocurrent response (Urbach tail) was attributed to sub bandgap defect states. The room temperature PL of the crystals was attributed to radiative recombination via tail states, with lifetimes in the nanosecond range. At high excitation intensities, the PL spectrum also showed evidence of direct band to band transitions at ~ 1.6 eV with a shorter decay time. Electrolyte electroreflectance spectra and spectra of the third derivative of the optical dielectric constant in the bandgap region were fitted to two optical transitions at 1.71 and 1.81 eV suggesting a larger valence band splitting than predicted theoretically. The high values of the EER broadening parameters (192 meV) indicate residual disorder consistent with the existence of tail states.

INTRODUCTION

The kesterites $\text{Cu}_2\text{ZnSnS}_4$ (CZTS) and $\text{Cu}_2\text{ZnSnSe}_4$ (CZTSe) continue to excite interest as potential earth-abundant alternatives to $\text{CuIn}_x\text{Ga}_{(1-x)}\text{Se}_2$ (CIGSe) for application as absorber materials in thin film solar cells.²⁻⁶ By 2014, the efficiency of kesterite solar cells had reached 12.6%,⁷ but progress since then has focused mainly on developing safer non-toxic routes to fabrication of CZTS(Se) absorber layers. The main limiting factor for device performance is the open circuit voltage, which is ~200 mV lower than that of CIGSe cells

with comparable bandgaps. The reasons for the voltage losses in kesterite cells are still not clear.⁶ One possible cause is enhanced recombination due to tail states arising from Cu/Zn disorder,^{8, 9} but a recent review of the evidence for this explanation failed to reach a firm conclusion.¹⁰ Alternative explanations include enhanced surface recombination at grain boundaries¹¹ and the influence of secondary phases.⁶ In order to discover more about the bulk properties of CZTS, we have grown single crystals with different stoichiometric compositions by iodine vapor transport¹² (with and without the addition of NaI as a sodium source) and have characterized their optoelectronic properties using photocurrent spectroscopy with electrolyte contacts (PS) as well as electrolyte electroreflectance spectroscopy (EER), spectroscopic ellipsometry (SE), Raman spectroscopy and photoluminescence (PL).

It is possible to grow single phase kesterite materials with significant deviations from stoichiometry.¹³ In this work, we have focused on zinc rich/copper poor and tin rich/copper poor materials because copper-poor stoichiometries give the best efficiencies in solar cells.¹⁴ Our primary objectives included determination of the stoichiometry and bandgap of the single crystals and assessment of the optical properties. In addition, we have examined the dependence of the degree of

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Electronic Supplementary Information (ESI) available: Oven cooling curve. Raman spectra/fitting. Comparison of SE data with ref.¹ Vineyard model and calculations. PL spectra/decay for needle. Tauc and Urbach plots. Gärtner analysis. Impedance data. EER results and validation of low field approximation. See DOI: 10.1039/x0xx00000x

substitutional disorder on composition and annealing conditions.

Analysis of the single crystal X-ray diffraction data from the $\text{Cu}_2\text{ZnSnS}_4$ crystals is unable to demonstrate unequivocally that they have the kesterite structure. Dumcenco et al.¹⁵ have used Raman scattering to establish that CZTS crystals grown by chemical vapor transport adopt the kesterite phase. For our crystals, the presence of the kesterite phase is supported by the peak assignments in the near-resonance Raman spectra, which also showed that the as-grown crystals have a low level of disorder comparable with that achieved by low temperature (150°C) annealing of fully disordered crystals for 24 hours.

The results obtained by PS for etched single crystals indicate that carrier collection is highly efficient in the voltage-biased single crystal/electrolyte junction, with external quantum efficiencies (EQE) corrected for reflection approaching 100%. The experimental EQE spectrum was compared with spectra calculated for different carrier collection depths using the absorption coefficient data obtained by spectroscopic ellipsometry (SE). The onset seen in the photocurrent excitation spectrum is much sharper than in the absorption spectrum derived from SE, allowing more reliable determination of the bandgap from Tauc plots. The bandgap values obtained by the Tauc/EQE analysis (1.64 – 1.68 eV) are close to the 1.64 eV reported by Fernandes et al.¹⁶ for CZTS layers prepared from sulfurized metallic precursors, although they are considerably higher than values reported, for example, by Li et al.¹ for polycrystalline thin films prepared by reactive sputtering (1.55–1.59 eV). Line shape fitting of the EER spectra and the third derivative of the optical dielectric constant obtained by SE reveals two optical transitions at 1.71 eV and 1.81 eV with substantial spectral broadening ($\Gamma = 192$ meV) attributed to the presence of residual disorder, even in as-grown slow-cooled samples with near equilibrium disorder. The observed separation between the two transitions (100 meV) is larger than the crystal field splitting calculated for kesterite CZTS (40 meV) by Persson et al.¹⁷

EXPERIMENTAL DETAILS

The synthesis of CZTS single crystals using iodine vapor transport in a two zone furnace has been described elsewhere.¹² The CZTS starting materials were synthesized in evacuated sealed quartz ampules using the metals (Cu 99.7%, Zn 99.9%, Sn 99.85%) and elementary sulfur (99.999%). Vapor transport growth was carried out using 99.999% iodine. The effect of adding sodium was investigated in one of the growth runs by adding 1% (w/w) sodium iodide (99+%) to the CZTS starting material. The crystals were cooled naturally to room temperature over 24 hours after the oven was switched off. Further details, including the stoichiometric composition of the synthesis mixtures as well as the oven cooling curve are given in the electronic supplementary information (ESI). The as-grown crystals were rinsed in chloroform and isopropanol to remove traces of iodine.

Single-crystal X-ray diffraction (SXRD) data were collected at room temperature operating with Mo- K_α radiation ($\lambda =$

0.71073 Å) (Agilent Xcalibur). Structures were solved using the WinGX suite of programmes,¹⁸ utilizing XPREP¹⁹ and SHELX-97,²⁰ by direct methods.²¹ For the two crystal types obtained (needles and platelets), analysis was undertaken using the models reported in the literature for kesterite (in space group I-4) and stannite (space group I-4 2m) descriptions of $\text{Cu}_2\text{ZnSnS}_4$.²²

Elemental analysis of the materials was carried out using energy-dispersive X-ray spectroscopy (EDS) (10 and 20 kV, Oxford Instruments).

Near-resonance Raman measurements were performed at room temperature under ambient atmosphere (Renishaw inVia). A linearly polarized laser beam (785 nm) was focused into a spot size ~ 5 μm in diameter. Prior to the measurements, the system was calibrated with polycrystalline Si at 520 cm^{-1} .

The crystals were etched in saturated Na_2S solution followed by 30% H_2O_2 /1 M H_2SO_4 . After rinsing, the samples were treated with 1 M HCl, to remove metal (hydr)oxides.

Further details of the PC, PL, EER, SE and Raman measurements and fitting procedures are given in the ESI. For the PC and EER measurements, the mounted and etched kesterite crystals were contacted on the abraded rear side with an evaporated gold contact. Measurements were made using an air-saturated 0.1 M acetate buffer electrolyte (pH 4.5) in a 3-electrode cell with platinum counter and Ag|AgCl reference electrodes controlled by a battery-operated low-noise potentiostat.

RESULTS AND DISCUSSION

Composition and degree of disorder of the kesterite phase.

Two main crystal shapes were obtained from the iodine vapor transport growth: needles (no sodium present in starting material) and platelets (1% w/w NaI present in starting material). Fig. 1 shows examples of the two types. Both crystals exhibited one smooth reflective surface suitable for SE and EER measurements.

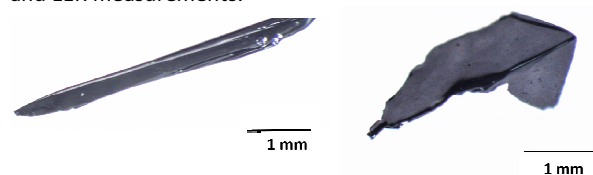


Fig. 1. Typical shapes of the $\text{Cu}_2\text{ZnSnS}_4$ crystals grown by iodine vapor transport. The platelet on the right was grown from CZTS starting material containing 1% (w/w) NaI

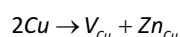
The averaged elemental compositions of the crystals determined by EDS at 6 different points on each crystal are summarized in Table 1. The standard deviations are shown in brackets. The level of sodium (if present) in the platelet was below the limit of detection by EDS (the sensitivity is limited by the overlap of the Na and Zn peaks). The sodium concentration determined by atomic absorption spectroscopy corresponded to 0.13 mol% in the platelet sample. No iodine was detected in either crystal after rinsing in chloroform and isopropanol.

Table 1. Elemental composition of $\text{Cu}_2\text{ZnSnS}_4$ crystals as determined by energy dispersive X-ray spectroscopy

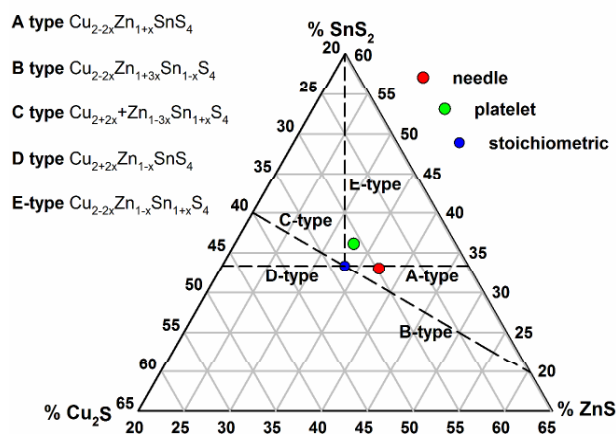
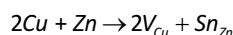
Type	Cu	Zn	Sn	S
needle	22.6 (± 0.4)	14.2 (± 0.9)	12.5 (± 0.4)	50.7 (± 0.4)
platelet	22.8 (± 0.6)	12.1 (± 0.6)	13.3 (± 0.7)	51.9 (± 1.0)

The compositions of the two types of crystal are illustrated in the pseudo ternary phase diagram shown in Fig. 2. The classification into type A, B, C, D and E follows the notation used by Choubrac et al.²³⁻²⁵

The needle composition is close to the A type line, which corresponds to the substitution



whereas the platelet stoichiometry is closer to the E type²⁶ line, which corresponds to the substitution

Fig. 2. Pseudo-ternary phase diagram for $\text{Cu}_2\text{ZnSnS}_4$ showing composition of the two sample types used in the study

XRD Structure Analysis

Distinguishing between the kesterite and stannite structures of CZTS, which differ only in the ordering of the near isoelectronic copper and zinc atoms is not generally possible using laboratory X-ray data. Only anomalous-scattering X-ray single crystal diffraction²⁷ and neutron single crystal diffraction can fully distinguish the two copper and zinc distributions. Powder neutron diffraction has been proposed as a way of distinguishing the two structure descriptions,²⁸ but this approach is not reliable as a consequence of peak multiplicities in powder methods. In addition to the copper and zinc ordering, the sulfur position in the kesterite I-4 space group can be displaced on to a general (x, y, z) position (from x, x, z), potentially modifying reflection intensities.

For both needle and platelet crystals, the structure was solved and refined using the kesterite model in the space group I-4.

For the platelet, a final R_1 of 2.68 % and wR_2 = 7.04 % was obtained, and corresponding values for the needle were R_1 =

2.13 % and wR_2 = 6.24 %. Refinements using the disordered stannite description showed marginally worse R-factors but not significant enough to completely discount the stannite structure. No evidence of lowering of the lattice type to primitive, as in the P-42c description of Cu/Zn ordered CZTS, was observed in the single crystal XRD data. The results are summarized in Table 2.

Table 2. Summary of Single Crystal XRD analysis

	Needle	Platelet
a/Å	5.4282(1)	5.4289(1)
c/Å	10.8198(5)	10.8256(5)
unit cell volume / Å ³	318.809(19)	319.062(19)
temperature / K	298	298
R indices observed data	$R_1 = 0.0213$	$R_1 = 0.0268$
	$wR_2 = 0.0624$	$wR_2 = 0.0704$
Goof	1.038	0.846

Small but significant differences in the unit cell volume were found for the two crystal types, with the platelets giving a 0.08 % higher value than the needle.

In view of the problems with the XRD interpretation, identification of the crystal structure as that of the kesterite was based on the Raman analysis described in the next section.

Raman Spectroscopy: Phase Identification and Disorder. Dumcenco et al.¹⁵ used Raman spectroscopy to identify the kesterite crystal structure of CZTS single crystals grown by chemical vapor transport. These authors compared the observed Raman spectra with the results of theoretical calculations^{29, 30} for the kesterite and stannite crystal structures. A similar analysis for both types of our as-grown crystals confirms that they too have the kesterite structure (see the peak assignments and comparison with the results of the theoretical calculations given in the ESI).

Disorder is a key issue in kesterites.^{8, 10, 28, 31, 32} Studies of the order/disorder transition in CZTS^{26, 33, 34} have shown that the degree of Cu/Zn antisite disorder exhibits second-order phase transition behaviour, with the complete disorder occurring at temperatures above ca. 280°C. Paris et al.³⁵ have shown how solid state NMR and Raman spectroscopy can be used to assess disorder in CZTS, and Rudisch et al.³³ have correlated Raman spectra with the degree of Cu/Zn disorder defined by the order parameter S, which is given by

$$S = \frac{P(\text{Cu}_{2c}) - a_{2c}}{1 - a_{2c}} = 2P(\text{Cu}_{2c}) - 1 = 2P(\text{Zn}_{2d}) - 1 \quad (1)$$

Here $P(\text{Cu}_{2c})$ and $P(\text{Zn}_{2d})$ are the probabilities that Cu and Zn atoms occupy the 2c and 2d sites in the kesterite structure respectively, and a_{2c} (= 0.5) is the fraction of 2c sites in the $z = \frac{1}{4}, \frac{3}{4}$ lattice planes as discussed by Scragg et al.⁸

Rey et al.³⁶ have discussed the dynamics of the order/disorder transition for $\text{Cu}_2\text{ZnSnSe}_4$ (CZTSe) using the Vineyard model,³⁷ which predicts the temperature and time dependence of S for vacancy and direct interchange mechanisms (see ESI). Since we are dealing with a second order phase transformation, perfect

ordering can only exist at 0 K. In practice, the highest achievable value of S is determined by the temperature dependence of the kinetics of atom interchange: at low temperatures (below ca. 150 °C), the disorder becomes 'frozen in' on a realistic time scale. The calculations based on the Vineyard model that are shown in the ESI suggest that the highest values of S achievable by prolonged low temperature annealing will be in the range 0.7-0.8.

The degree of ordering of the as-grown crystals was assessed from near-resonance Raman spectra (excitation 785 nm). Fig. 3 contrasts the Raman spectrum of an as-grown platelet with the spectrum obtained after annealing at 300 °C and quenching to freeze in complete disorder. The fully disordered crystal was then annealed at 150 °C for 24 hours to induce equilibrium ordering (cf. Fig. 3). The Raman spectrum of this sample resembles that of the as-grown crystal, indicating that near-equilibrium ordering occurs during the slow cooling of the crystals in the furnace. Similar trends in S as a function of annealing temperature have been reported by Rudisch et al.³³ for polycrystalline CZTS films prepared by reactive sputtering.

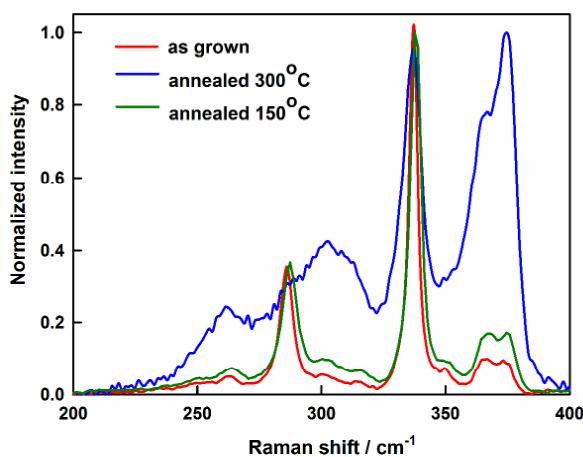


Fig. 3. Near-resonance Raman spectrum of as-grown CZTS platelet crystal compared with the spectrum of the fully disordered crystal (annealed at 300 °C). The spectrum obtained after annealing the disordered crystal for 24 hrs at 150 °C shows that near-equilibrium ordering is re-established.

Paris et al.³⁵ have suggested that a measure of the degree of Cu/Zn disorder is provided by the use of two empirical parameters, Q and Q' , defined in terms of the intensity ratios of the main near-resonance Raman peaks as follows.

$$Q = \frac{I_{287}}{I_{303}} \quad Q' = \frac{I_{338}}{(I_{366} + I_{374})} \quad (2)$$

Fig. 4 illustrates the deconvolution of the Raman spectra used to obtain the relative peak intensities for the case of the disordered platelet sample. The deconvolution of the Raman spectrum of the ordered platelet as well as the spectrum for the as-grown needle sample are given in the ESI. Table 3 lists the Q and Q' values obtained using spectra measured on the platelet sample at two different spots and averaged before and after disordering.

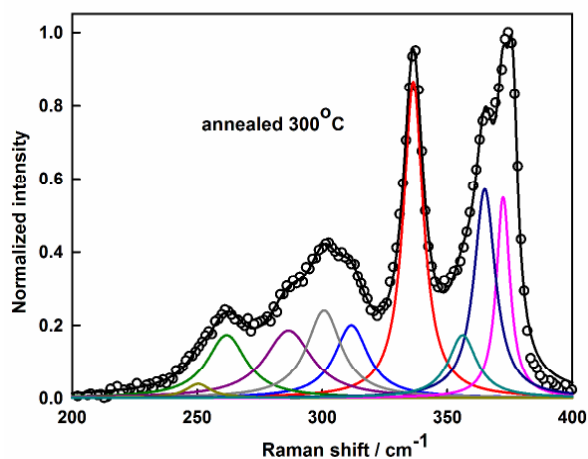


Fig. 4. Illustration of the fitting of the near-resonance Raman spectrum of the fully disordered CZTS platelet used to obtain the parameters Q and Q' .

Table 3. Q and Q' values of copper-poor platelet sample as a function of annealing conditions

Annealing	Q	Q'
as-grown	9.1 ± 1.1	5.7 ± 0.3
annealed 300 °C	0.75 ± 0.40	0.8 ± 0.1

For of the as-grown platelet, Q is higher than values reported for low temperature annealed CZTS films prepared by Scragg et al.⁹ (stoichiometric CZTS, $Q < 2.5$) and by Rudisch et al.³³ (type B CZTS, $Q < 3.3$) using reactive sputtering. It is also higher than the value of 8.2 reported by Paris et al.³⁵ for slow-cooled (10 °C/hr) - and hence relatively highly ordered - bulk polycrystalline type A CZTS. Similarly, Q' is higher than the value of 3.6 reported by the same authors for slow-cooled type A material.

We conclude that the as-grown platelet used in our study has ordering close to the equilibrium value for ~100-150 °C. The corresponding S value is unknown, but if the Vineyard model calculation in the ESI is used as a guide, it would be in the range 0.7 - 0.8. Even if this level of ordering were achieved, it would still leave around 20 - 30% of the sites disordered, with significant consequences for band gap fluctuations and band gap tailing.

The Q and Q' values for the as-grown needle sample are both lower at around 5 and 3.5 respectively, suggesting that it may be less ordered than the platelet.

Photoluminescence

Fig. 5 shows the room temperature PL spectrum of the platelet crystal. The peak of the spectrum at 1.35 eV is substantially red shifted with respect to the bandgap of the material (1.68 – 1.71 eV – see below), which is consistent with emission taking place from tail states associated with disorder in the crystal. The intensity dependence of the peak position shown in the inset to Fig. 5 corresponds to a blue shift of 13 meV/decade, which agrees well with reported values.^{38, 39}

The PL spectrum for the needle exhibits a similar blue shift with a higher slope of 18 meV/decade (see ESI). The blue shift seen for both CZTS crystals can be interpreted as an indication of potential fluctuations in the material.⁴⁰

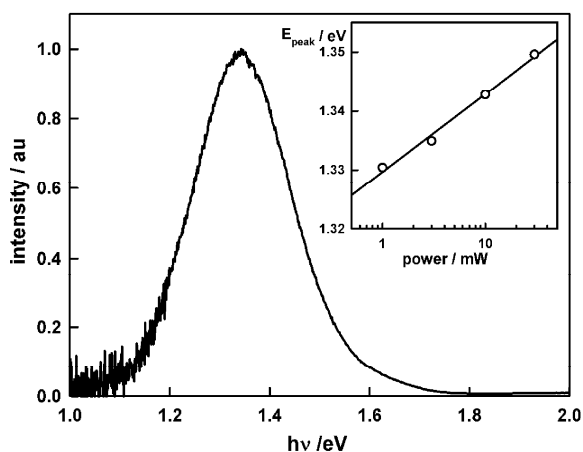


Fig. 5. Room temperature PL spectrum of CZTS platelet (laser intensity 10 mW). The inset shows the blue shift of the PL emission peak with increasing intensity.

The dependence of the PL emission intensity on laser power for different samples (shown in the ESI) corresponds to a power law $PL \propto I^m$, with m values ranging from 1.3 – 1.6. Levchenko et al. have reported a similar m value (1.3) for solution-processed CZTS layers. In the case of low temperature PL, m values greater than unity are usually attributed to band to band transitions,⁴¹ but the value has more limited significance in the case of room temperature PL. Nevertheless, we conclude that the main PL peak is associated with near band edge (tail) states.

At higher intensities, a second peak becomes evident as a shoulder in the room temperature PL spectrum as illustrated by the semi-logarithmic plot in Fig. 6. Gershon et al.⁴² have reported the emergence of a higher energy PL peak for high efficiency CZTS devices measured at 4K, and have attributed it to free carrier recombination. These authors compared the PL lifetimes at 4K for the low energy (1.16 eV) and high energy (1.43 eV) peaks. The low energy emission decayed on a time scale of microseconds (lifetime ca 12 μ s), indicating carrier trapping, whereas the high-energy component gave a much shorter lifetime of 1.7 ns, which is attributed to free carrier recombination not requiring activation by thermal excitation from tail states. Although there are problems in comparing low temperature measurements with our results, it seems

reasonable to assume that the high-energy peak in the room temperature PL spectrum shown in Fig. 6 is due to band to band recombination, whereas the low energy peak corresponds to emission from tail states.

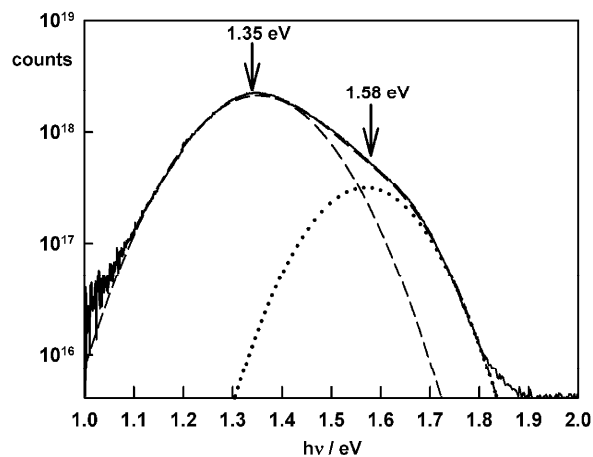


Fig. 6. PL spectrum of CZTS platelet showing shoulder at higher energy attributed to radiative band to band recombination (laser power 50 mW).

PL transients measured at room temperature for the platelet are illustrated in Fig. 7. The decay is slower when measured at 1.30 eV compared with 1.65 eV. The lifetimes obtained from the exponential fits shown in Fig. 7 are 3.5 ns (1.65 eV) and 6.8 ns (1.30 eV), similar to the 7.8 ns reported by Shin et al.⁴³ for an 8.4% efficient CZTS solar cell. However, the decay rates at the two photon energies are almost identical in the case of the needle ($\tau = 3.6$ ns: see ESI).

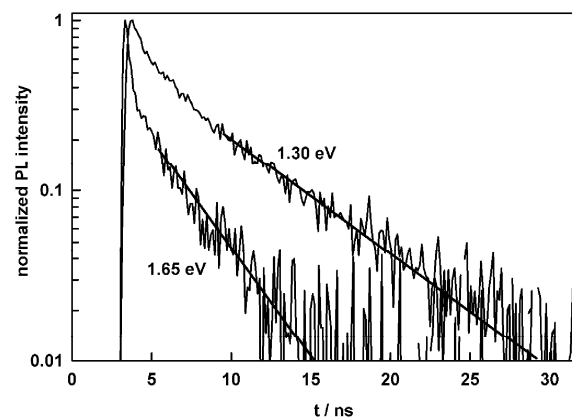


Fig. 7. Transient PL response of the CZTS platelet. Excitation energy 1.96 eV. Detection energies as shown.

The lifetimes derived here may not correspond to the lifetime of free electrons moving in CZTS since multiple trapping processes may be involved.^{39, 44-46} This makes it difficult to calculate electron diffusion lengths, since the electron mobility will be reduced from the free electron value by multiple trapping. Phoung et al.⁴⁵ have used time-resolved femtosecond transient reflectance and optical pump-probe

terahertz spectroscopy to study free carrier dynamics in CZTS single crystals, and they attribute the relatively long (ns) electron lifetimes to thermal release of carriers from tail states.

Spectroscopic Ellipsometry

Spectra of the real and imaginary components of the optical dielectric constant and the absorption coefficient obtained by fitting the ellipsometric data for the platelet sample are shown in Fig. 8. Details of the fitting, as well as results for the needle sample, are given in the ESI, which also includes a comparison with published optical data. The fitting used oscillators centred at 1.81, 2.60 and 4.27 eV. The absorption coefficient shows an exponential Urbach tail extending into the near infrared that is discussed below.

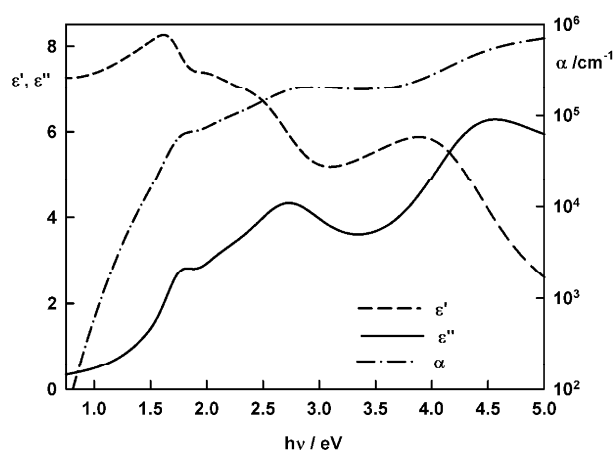


Fig. 8. Real and imaginary components of the optical dielectric constant for the CZTS platelet measured by spectroscopic ellipsometry. The figure also shows the absorption coefficient derived from the measurement.

EQE Measurements

Durant et al.⁴⁷ have reported electrolyte EQE measurements of natural kesterite crystals, but as far as we are aware, no detailed study of the photoresponse of synthetic CZTS crystals in contact with an electrolyte have been published previously. The EQE response of the single crystals was found to be strongly influenced by surface preparation. High EQE values could be obtained immediately after etching, but the photoresponse decayed slowly with time. The external quantum efficiency (EQE) for the semiconductor/electrolyte junction in the absence of surface recombination is given by the expression originally derived by Gärtner.⁴⁸

$$EQE = 1 - \frac{\exp(-\alpha W)}{1 + \alpha L_n} \quad (3)$$

Here W is the width of the space charge region, α is the wavelength dependent absorption coefficient and L_n is the diffusion length of electrons.

The EQE response of a freshly etched platelet crystal is shown in Fig. 9. Since the reflection loss is estimated to be of the

order of 10% in the region where the EQE reaches a plateau, the spectrum indicates that essentially all photogenerated electrons are collected in the junction for photon energies above 1.7 eV. It follows that the second term on the right-hand side of the Gärtner equation must become negligible under these conditions. Near the band edge, we can assume that $\alpha L_n < 1$. In this case $-\ln(1-EQE_{corr}) = \alpha W$ (here EQE_{corr} is the EQE corrected for reflection losses).

Plots of $(\alpha hv)^2$ vs. hv are commonly used to estimate the direct allowed bandgap (Tauc plots). The inset in Fig. 9 shows a plot of $[-hv \cdot \ln(1-EQE_{corr})]^2$ vs. photon energy, which is equivalent to the Tauc plot for a direct allowed transition. The intercept at 1.68 eV should therefore correspond to the optical bandgap, E_g , of the CZTS. A similar plot for the needle crystal gave a slightly lower bandgap of 1.64 eV (see ESI). Tauc plots of the optical SE data for the platelet gave a slightly lower bandgap of 1.61 eV (see ESI).

The exponential tail evident in the SE, EQE and Tauc plots is consistent with the existence of an Urbach tail associated with disorder in the CZTS crystal. The difficulties encountered when using Tauc plots for systems with sub-bandgap absorption (tail states) have been highlighted for the case of kesterites by Siebentritt et al.,⁴⁹ and these bandgap values should be considered approximate. As shown in the ESI, the EQE response in the sub-bandgap energy range 1.4 – 1.7 eV can be fitted to an exponential Urbach distribution with $E_U = 2.2k_B T$, which is considerably lower than the E_U value ($6.7k_B T$) derived from the SE data for the same energy range (see ESI). The difference in Urbach energies suggests that lower energy optical transitions in the tail region lead to bound electron-hole states that require thermal activation to produce current in the external circuit and therefore have a lower chance of separation before recombination occurs.

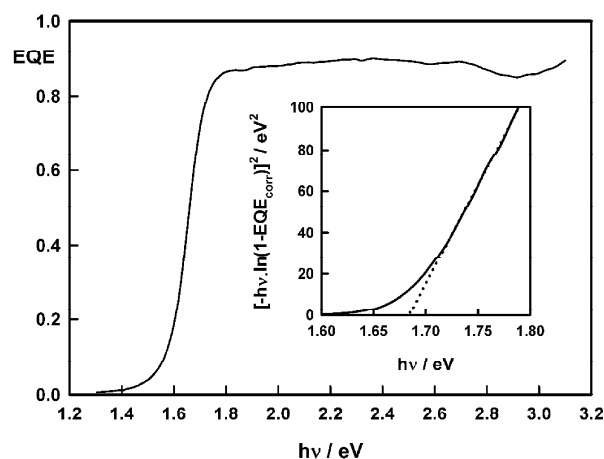


Fig. 9. EQE spectrum of CZTS platelet (uncorrected for reflection losses). Electrolyte; 0.1 M acetate buffer pH 4.5. Potential -1.0 V vs. Ag/AgCl. The inset shows a Tauc plot for a direct allowed transition ($E_g = 1.68$ eV).

If the semiconductor/electrolyte junction behaved ideally, the width of the space charge region should be controlled by the applied electrode potential, U , obeying the relationship $W \propto$

$(U_{fb}-U)^{1/2}$, where U_{fb} is the flat band potential. Unfortunately, in the present case, attempts to measure the space charge capacitance as a function of applied potential by impedance spectroscopy revealed that the junction is not ideal due to the presence of a high surface state capacitance (see ESI). This precluded full analysis of the potential dependence of the EQE spectra based on equation 3, which can in principle give the absorption coefficient and the electron diffusion length, as demonstrated for p-GaP for example.⁵⁰ Nevertheless, the 'square' shape of the EQE spectrum in Fig. 9 shows that collection of minority carriers is very efficient even when the penetration depth of the light is large near the band edge. By contrast, the EQE spectra reported for high-performance CZTS solar cells generally show a slower rise from 1.4 eV to a peak at around 2.3 eV – see, for example, the EQE spectrum for a 2 μ m CZTS absorber layer in a recent paper by Ren et al.⁵¹

Fig. 10 compares the measured EQE corrected for reflection losses with EQE plots calculated from the Gärtner equation (equation 3) for different values of the collection depth $W + L_n$ using values of the absorption coefficient derived from the SE measurements (cf. Fig. 8). Since reported doping densities for CZTS are of the order of 10^{16} cm^{-3} , the width of the space charge region under the conditions employed for EQE measurements has been taken as 300 nm (see ESI). Using this value, the effect on the EQE spectrum of increasing the electron diffusion length was explored, and representative results are shown in Fig. 10. The fitting above ca. 1.75 eV indicates that the collection depth for minority carriers approaches 1 μ m. This rather high value could indicate that the doping density is lower than assumed in the calculation. In the limit that $L_n \ll W$, W would be 1 μ m, and the doping density would have to be ca. 10^{15} cm^{-3} to fit the spectrum (see ESI).

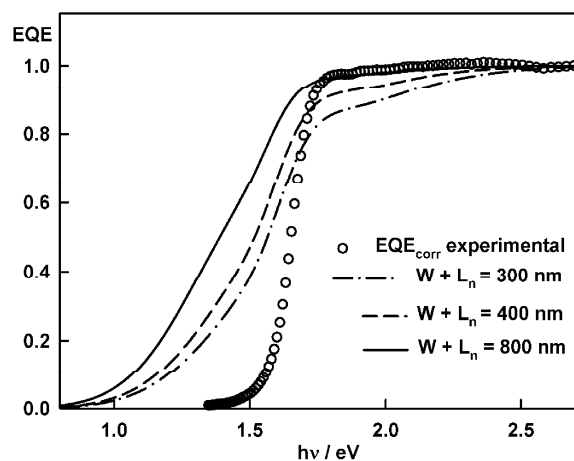


Fig. 10. Comparison of experimental EQE (Fig. 9, corrected for reflection losses) with EQE calculated using equation 3 for the collection depth values shown. W was taken as 300 nm for the calculations, and L_n was varied. The α values were derived by spectroscopic ellipsometry.

It is apparent that the experimental EQE spectrum shows a much steeper onset than the spectra calculated using the α values obtained by SE. This can be explained if it is assumed that absorption of light in tails states below the band edge leads to bound states for which thermal excitation to create free charge carriers must compete with recombination.

Electrolyte electroreflectance

Electrolyte electroreflectance (EER) is a powerful technique for obtaining the bandgap of semiconductors. The method involves perturbing the electrical field in the space charge region by ac voltage modulation and detecting the synchronous changes in reflectance. Under low field conditions, the EER spectrum corresponds to the third derivative of the imaginary component of the optical dielectric constant,⁵² and the results can be compared with those obtained by spectroscopic ellipsometry.⁵³ EER spectra can be modelled using a broadening parameter Γ that can be related to disorder and non-stoichiometry.^{54, 55} EER should therefore be a useful technique for characterizing cation disorder in CZTS. Fig. 11 shows the EER spectrum of the platelet crystal. A very similar EER spectrum was obtained for the needle (see ESI).

Successful fitting of the EER spectrum required the use of two generalized line shape functions of the form proposed by Aspnes.^{52, 56}

$$\frac{\Delta R}{R} = \text{Re} \left[C e^{i\theta} (E - E_g - i\Gamma)^n \right] \quad (4)$$

with $n = 5/2$ (3D critical point). Here $\Delta R/R$ is the normalized modulated reflectance, C is a scaling factor, θ is the phase projection factor, E is the photon energy, E_g is the bandgap energy and Γ is the broadening parameter. The EER response was found to depend linearly on the modulation amplitude, indicating that the low field expression is applicable⁵² (see ESI).

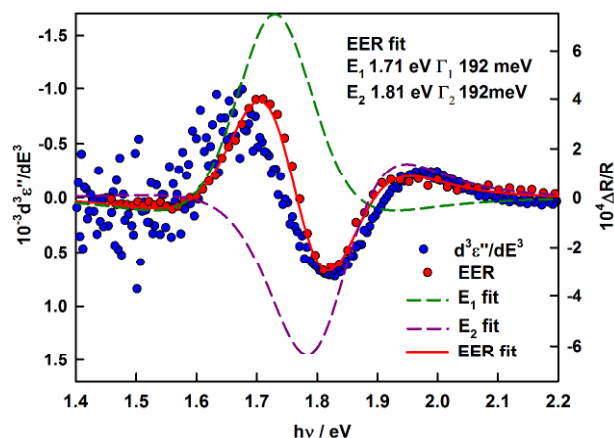


Fig. 11. EER spectrum of CZTS platelet showing fit to two transitions. The plot also shows the third derivative of the ϵ'' spectrum obtain by spectroscopic ellipsometry.

The fit shown in Fig. 11 corresponds to a superposition of two transitions at 1.71 eV and 1.81 eV, both values being higher

than the bandgap, of ca. 1.68 eV derived from the Tauc plot in Fig. 9. The high Γ values obtained by the fitting of the EER spectra for CZTS provide further evidence of disorder leading to band energy fluctuations that effectively broaden the optical transitions (typical Γ values for single crystal binary semiconductors are considerably smaller, for example 53 meV for CdTe⁵⁷). To check whether the EER spectrum does indeed correspond to the third derivative of ϵ'' as predicted by the Aspnes analysis, the SE data for the platelet crystal were differentiated, giving the result included in Fig. 11. The agreement confirms that the low field approximation is indeed valid.

The well-resolved EER spectrum shown in Fig. 11 differs significantly from spectra in the literature. Levenco et al.⁵⁸ have reported room temperature EER spectra for CZTS single crystals grown by ICl₃ vapor transport, and their spectra (only shown over the range 1.2 to 1.6 eV) show a single peak at around 1.45 eV with very little response at higher energies. These authors also used the generalized line shape to analyse their EER spectra and reported A and B transitions at 1.457 eV and 1.464 eV. However, the line shapes of our EER spectra resemble more the EER spectra reported for CZTSe solar cells by Krämmer et al.⁵⁹ and by Krustok et al.⁶⁰ Clearly more work is needed to understand why our EER spectra differ so much from those reported in reference⁵⁸.

CONCLUSIONS

Single crystals of CZTS have been grown with near-equilibrium disorder, as shown by near-resonance Raman spectroscopy. The band tail seen in the optical properties is attributed to residual disorder, which is also responsible for the red shift of the room temperature photoluminescence peak relative to the bandgap. The EQE spectra show much less evidence of the band tail, and this is attributed to a lower electron-hole separation efficiency for bound states created by sub-bandgap absorption. The bandgaps derived from Tauc plots of the optical and EQE data are in the range 1.60 - 1.64 eV, whereas the fitting of EER spectra indicates two adjacent transitions at higher energies (1.71 and 1.81 eV). This highlights the difficulty of using Tauc plots to determine the band gap in materials that have a high density of tail states.

The 100 meV separation of the transitions seen in the EER spectra could arise from crystal field splitting of the valence band, although it is higher than the 40 meV calculated by Persson et al.¹⁷ for 0 K. The high value of the EQE in the plateau region of the EQE spectrum indicates 100% collection efficiency of photogenerated electron-hole pairs, while the shape of the spectrum is consistent with a collection depth approaching 1 μ m. The electron lifetimes measured by PL decay are in the range 3.5 – 6.8 ns.

The effect on the optoelectronic properties of including a sodium source in the starting materials for CZTS crystal growth appear to be minor. This may indicate that the beneficial influence of sodium on the performance of CZTS solar cells is more likely to be associated with grain boundary effects.

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